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Key indicators

Single-crystal X-ray study T = 298 K Mean σ (C–C) = 0.004 Å R factor = 0.055 wR factor = 0.165 Data-to-parameter ratio = 13.7

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

1-[2,6-Dichloro-4-(trifluoromethyl)phenyl]-5-(2,5-dioxo-2,5-dihydro-1*H*-pyrrol-1-yl)-1*H*-pyrazole-3-carbonitrile

The title compound, $C_{15}H_5Cl_2F_3N_4O_2$, is a tricyclic imide with an overall U-shape, each of the three rings being planar. These include a phenyl ring with two chloro and one trifluoromethyl substituents, a central pyrazole ring with a cyano substituent, and a dioxopyrrolidine ring.

Comment

Reaction of 2,6-dichloro-4-trifluoromethylamine with a suspension of nitrosyl sulfuric acid, followed by reaction with a solution of ethyl 2,3-dicyanopropionate in acetic acid, gave 5-amino-3-cyano-1-[2,6-dichloro-4-(trifluoromethyl)phenyl]-pyrazole. When the latter was reacted with maleic anhydride, the title compound, (I), was obtained.



Compound (I) has been used to synthesize 5-amino-3cyano-1-[2,6-dichloro-4-(trifluoromethyl)phenyl]-4-(trifluoromethyl)thiopyrazole, 5-amino-3-cyano-1-[2,6-dichloro-4-(trifluoromethyl)phenyl]-4-(trifluoromethylsulfenyl)pyrazole and 5-amino-3-cyano-1-[2,6-dichloro-4-(trifluoromethyl)phenyl]-4-(trifluoromethylsulfonyl)pyrazole, all of which are good insecticides (Hatton *et al.*, 1993).

The molecular structure of compound (I) is illustrated in Fig. 1, and selected bond lengths and angles are given in Table 1. The molecule is composed of three planar moieties, *viz*. a benzene ring, a central pyrazole ring and a dihydropyrrole ring. The angle between the benzene and pyrazole planes is $75.49 (14)^{\circ}$, and that between the dihydropyrrole and pyrazole planes is $49.62 (16)^{\circ}$.

In the crystal structure, the molecules stack along the *b* axis, as shown in Fig. 2, and are connected by weak $C-H \cdots O$ and $C-H \cdots N$ hydrogen bonds (Table 2).

Experimental

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Compound (I) was synthesized and purified according to the method of Hatton *et al.* (1993). Single crystals suitable for X-ray analysis were



Figure 1

The molecular structure of (I), showing the atomic numbering scheme and displacement ellipsoids at the 50% probability level.



Figure 2

The crystal packing of (I), viewed down the c axis.

obtained on slow evaporation of an ethyl acetate/cyclohexane (1:1) solution (m.p. 462–464 K). Spectroscopic analysis, IR (KBr, ν cm⁻¹): 3089, 2253, 1742, 1562, 1497; ¹H NMR (CDCl₃, p.p.m.): 7.71 (s, 2H), 6.88 (s, 1H), 6.85 (s, 2H).

Crystal data

$C_{15}H_5Cl_2F_3N_4O_2$	$D_x = 1.622 \text{ Mg m}^{-3}$
$M_r = 401.13$	Mo $K\alpha$ radiation
Monoclinic, $P2_1/n$	Cell parameters from 3254
a = 12.8261 (10) Å	reflections
b = 8.9942 (7) Å	$\theta = 2.4 - 26.0^{\circ}$
c = 14.6896 (12) Å	$\mu = 0.45 \text{ mm}^{-1}$
$\beta = 104.217 \ (1)^{\circ}$	T = 298 (2) K
$V = 1642.7 (2) \text{ Å}^3$	Block, colorless
Z = 4	$0.43 \times 0.38 \times 0.20 \text{ mm}$
Data collection	
Bruker SMART APEX area-	3225 independent reflections

detector diffractometer φ and ω scans Absorption correction: multi-scan (SADABS; Bruker, 2002) $T_{\min} = 0.832, T_{\max} = 0.916$ 9003 measured reflections

3225 independent reflections
2660 reflections with $I > 2\sigma(I)$
$R_{\rm int} = 0.018$
$\theta_{\rm max} = 26.0^{\circ}$
$h = -15 \rightarrow 14$
$k = -11 \rightarrow 9$
$l = -18 \rightarrow 16$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0945P)^2]$
$R[F^2 > 2\sigma(F^2)] = 0.055$	+ 0.8386P]
$wR(F^2) = 0.165$	where $P = (F_o^2 + 2F_c^2)/3$
S = 1.06	$(\Delta/\sigma)_{\rm max} = 0.001$
3225 reflections	$\Delta \rho_{\rm max} = 0.72 \text{ e } \text{\AA}^{-3}$
235 parameters	$\Delta \rho_{\rm min} = -0.38 {\rm e} {\rm \AA}^{-3}$
H-atom parameters constrained	

Table 1

Selected geometric parameters (Å, °).

N1-N2	1.352 (3)	N2-C10	1.327 (3)
N1-C8	1.359 (3)	C8-C9	1.361 (4)
N1-C5	1.423 (3)	C9-C10	1.395 (4)
N3-C11	1.136 (4)	C10-C11	1.443 (4)
N4-C8	1.401 (3)	C12-C15	1.477 (4)
N4-C13	1.407 (3)	C14-C15	1.319 (4)
N4-C12	1.410 (3)		
N2-N1-C8	111.9 (2)	C8-C9-C10	103.8 (2)
N2-N1-C5	117.93 (19)	N2-C10-C9	113.3 (2)
C8-N1-C5	129.9 (2)	N2-C10-C11	117.8 (2)
C8-N4-C13	124.2 (2)	C9-C10-C11	128.9 (3)
C8-N4-C12	125.5 (2)	N3-C11-C10	178.7 (3)
C13-N4-C12	109.8 (2)	N4-C12-C15	105.7 (2)
C10-N2-N1	103.5 (2)	O1-C13-C14	129.0 (3)
N1-C8-C9	107.6 (2)	N4-C13-C14	105.5 (2)
N1-C8-N4	121.8 (2)	C15-C14-C13	109.5 (3)
C9-C8-N4	130.7 (2)		

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H	ydrogen-	bonding	geometry	(A, °).
		0	0 2	× /	/

$D - H \cdots A$	D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdots A$
$C7 - H7 \cdots O1^{i}$	0.93	2.50	3.380 (4)	157
$C14 - H14 \cdots N2^{ii}$	0.93	2.49	3.410 (3)	170

Symmetry codes: (i) $x - \frac{1}{2}, \frac{3}{2} - y, z - \frac{1}{2}$; (ii) x, 1 + y, z.

All H atoms were located in difference Fourier maps but were placed in geometrically idealized position and constrained to ride on their parent atom, with C-H distances of 0.93 Å and $U_{iso}(H) =$ $1.2_{eq}(C).$

Data collection: SMART (Bruker, 2002); cell refinement: SAINT (Bruker, 2002); data reduction: SAINT; program(s) used to solve structure: SHELXS97 (Sheldrick, 1997); program(s) used to refine structure: SHELXL97 (Sheldrick, 1997); molecular graphics: SHELXTL (Bruker, 2002); software used to prepare material for publication: SHELXL97.

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